

<b>Notice of References Cited</b>	Application/Control No. 10/520,364		Applicant(s)/Patent Under Reexamination KESZLER ET AL.	
	Examiner Daniel S. Metzmaier		Art Unit 1796	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,238,593	05-2001	Huguenin et al.	423/263
*	B	US-5,879,803	03-1999	Masaki et al.	428/378
*	C	US-4,791,927	12-1988	Menger, Eva L.	606/3
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Leonyuk N. I. and Leonyuk L.I., "Growth and Characterization of $\text{LaVl}_3(\text{LaIO}_3)_4$ Crystals," Prog. Crystal Growth and Charact., Vol. 31, 1995-month unavailable, pp. 1 & 263-278.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.